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INA828

SBOS792-AUGUST 2017

Reference

Design

# INA828 50-μV Offset, 7-nV/√Hz Noise, Low-Power, Precision Instrumentation Amplifier

Technical

Documents

# 1 Features

- Precision Instrumentation Amplifier Evolution:
  - Second Generation: INA828
  - First Generation: INA128
- Low Offset Voltage: 50 µV, MAX
- Gain Drift: 5 ppm/°C (G = 1), 50 ppm/°C (G > 1)
- Noise: 7 nV/√Hz
- Bandwidth: 2.0 MHz (G = 1), 260 kHz (G = 100)
- Stable with 1-nF capacitive loads
- Inputs Protected Up to ±40 V
- Common-Mode Rejection:
  - 110 dB, MIN (G = 10)
- Power-Supply Rejection: 100 dB, MIN (G = 1)
- Supply Current: 650 µA, MAX
- Supply Range:
  - Single Supply: 4.5 V to 36 V
  - Dual Supply: ±2.25 V to ±18 V
- Specified Temperature Range: -40°C to +125°C
- Package: 8-Pin SOIC

# 2 Applications

- Industrial Process Controls
- Circuit Breakers
- Battery Testers
- ECG Amplifiers
- Power Automation
- Medical Instrumentation
- Portable Instrumentation

# **INA828 Simplified Internal Schematic**



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# 3 Description

Tools &

Software

The INA828 is a high-precision instrumentation amplifier that offers low power consumption and operates over a very wide single- or dual-supply range. A single external resistor sets any gain from 1 to 1000. The device offers excellent precision due to the use of new super-beta input transistors which provide exceptionally low input offset voltage, offset voltage drift, input bias current, and input voltage and current noise. Additional circuitry protects the inputs against overvoltage up to  $\pm 40$  V.

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20

The INA828 is optimized to provide excellent common-mode rejection ratio. At G = 1, the common-mode rejection ratio exceeds 90 dB across the full input common-mode range. The device is well-suited for low-voltage operation from a 5-V single supply as well as dual supplies up to  $\pm 18$  V. Finally, INA828 is available in an 8-pin SOIC package and specified over the  $-40^{\circ}$ C to  $\pm 125^{\circ}$ C temperature range.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)			
INA828	SOIC (8)	4.90 mm × 3.91 mm			

(1) For all available packages, see the orderable addendum at the end of the data sheet.



#### Typical Distribution of Input Offset Voltage Drift



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# **Table of Contents**

1	Feat	tures	1
2	Арр	lications	1
3	Des	cription	1
4	Rev	ision History	2
5	Pin	Configuration and Functions	
6	Spe	cifications	4
	6.1	Absolute Maximum Ratings	4
	6.2	ESD Ratings	4
	6.3	Recommended Operating Conditions	4
	6.4	Thermal Information	4
	6.5	Electrical Characteristics	
	6.6	Typical Characteristics	7
7	Deta	ailed Description	16
	7.1	Overview	16
	7.2	Functional Block Diagram	16
	7.3	Feature Description	17
	7.4	Device Functional Modes	21
8	Арр	lication and Implementation	22

	8.1	Reference Terminal 22
	8.2	Input Bias Current Return Path 24
	8.3	PCB Assembly Effects on Precision 25
	8.4	Typical Application 26
	8.5	Other Application Examples 28
9	Pow	er Supply Recommendations 29
10	Lay	out 29
	10.1	Layout Guidelines 29
	10.2	Layout Example 30
11	Dev	ice and Documentation Support
	11.1	Documentation Support 31
	11.2	Receiving Notification of Documentation Updates 31
		Community Resources 31
	11.4	Trademarks 31
	11.5	Electrostatic Discharge Caution 31
	11.6	Glossary 31
12		hanical, Packaging, and Orderable mation
	mio	111auvii

# 4 Revision History

DATE	REVISION	NOTES
August 2017	*	Initial release.



# 5 Pin Configuration and Functions



#### **Pin Functions**

PIN		1/0	DESCRIPTION	
NAME	NO.	I/O	DESCRIPTION	
DC	1		Cain patting him Place a gain register between him 1 and him 9	
RG	8	_	Gain setting pin. Place a gain resistor between pin 1 and pin 8.	
–IN	2	I	I Negative (inverting) input	
+IN	3	I	I Positive (noninverting) input	
–VS	4	—	Negative supply	
REF	5	I	Reference input. This pin must be driven by a low impedance source.	
OUT	6	0	Output	
+VS	7	—	Positive supply	

# 6 Specifications

## 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
Supply voltage		-18	18	V
Cignal input pipe	Voltage	-40	40	V
Signal input pins	REF pin	-18	18	v
Output short-circuit <sup>(2)</sup>		Continuous	Continuous	
Temperature	Operating, T <sub>A</sub>	-50	150	
	Junction, T <sub>J</sub>		175	°C
	Storage, T <sub>stg</sub>	-65	150	

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) Short-circuit to V<sub>S</sub> / 2.

# 6.2 ESD Ratings

			VALUE	UNIT
V <sub>(ECD)</sub> Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±1500	V	
	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±750	V	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
Supply voltage	Single supply	4.5	36	V
	Dual supply	±2.25	±18	v
Specified temperature		-40	125	ů
Operating temperature	· · ·		150	

#### 6.4 Thermal Information

		INA828	
	THERMAL METRIC <sup>(1)</sup>	D (SOIC)	UNIT
		8 PINS	
$R_{ hetaJA}$	Junction-to-ambient thermal resistance	119.6	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	66.3	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	61.9	°C/W
ΨJT	Junction-to-top characterization parameter	20.5	°C/W
ΨЈВ	Junction-to-board characterization parameter	61.4	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	n/a	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

#### 6.5 Electrical Characteristics

at  $T_A = 25^{\circ}$ C,  $V_S = \pm 15$  V,  $R_L = 10$  k $\Omega$ ,  $V_{REF} = 0$  V, and G = 1 (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
INPUT						
		G = 100, RTI		20	50	μV
V <sub>OSI</sub>	Input stage offset voltage <sup>(1)(2)</sup>	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C^{(3)}$			90	μV
	vollage	vs temperature, $T_A = -40^{\circ}C$ to +125°C			0.5	µV/°C
		G = 1, RTI		50	250	μV
V <sub>oso</sub>	Output stage offset voltage <sup>(1)(2)</sup>	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C^{(3)}$			500	μV
000	voltage	vs temperature, $T_A = -40^{\circ}$ C to +125°C			5	μV/°C
		G = 1, RTI	110	120		•
	Power-supply rejection	G = 10, RTI	114	130		
PSRR	ratio	G = 100, RTI	130	135		dB
		G = 1000, RTI	136	140		
z <sub>id</sub>	Differential impedance			100    1		GΩ    pF
Z <sub>ic</sub>	Common-mode impedance			100    10		GΩ    pF
-IC	RFI filter, –3-dB frequency			53		MHz
			(V–) + 2		(V+) – 2	
V <sub>CM</sub>	Operating input range <sup>(4)</sup>	$V_{S} = \pm 2.25$ V to $\pm 18$ V, $T_{A} = -40^{\circ}$ C to $\pm 125^{\circ}$ C		Figure 48 to Figure 51	(()) 2	V
	Input overvoltage range	$T_{A} = -40^{\circ}C \text{ to } +125^{\circ}C$		iguro io to riguro or	±40	V
	input overvoltage range	At dc to 60 Hz, RTI, $V_{CM} = (V_{-}) + 2 V$ to $(V_{+}) - 2 V$ ,			140	v
	Common-mode rejection ratio	G = 1	90	100		
CMRR		At dc to 60 Hz, RTI, $V_{CM} = (V-) + 2 V$ to $(V+) - 2 V$ , G = 10	110	120		dB
		At dc to 60 Hz, RTI, $V_{CM} = (V-) + 2 V$ to $(V+) - 2 V$ , G = 100	130	140		
		At dc to 60 Hz, RTI, $V_{CM} = (V-) + 2 V$ to $(V+) - 2 V$ , G = 1000	140	145		
BIAS CU	JRRENT		-1		1	
		$V_{CM} = V_S / 2$		0.15	0.6	
B	Input bias current	$T_A = -40^{\circ}C$ to $+125^{\circ}C$			2	nA
		$V_{CM} = V_S / 2$		0.15	0.6	
los	Input offset current	$T_A = -40^{\circ}C \text{ to } +125^{\circ}C$			2	nA
NOISE V	/OLTAGE					
	Input stage voltage	f = 1 kHz, G = 100, R <sub>S</sub> = 0 Ω		7		nV/√ <del>Hz</del>
∋ <sub>NI</sub>	noise <sup>(5)</sup>	$f_{B} = 0.1$ Hz to 10 Hz, G = 100, R <sub>S</sub> = 0 $\Omega$		0.14		μV <sub>PP</sub>
	Output stage voltage	$f = 1 \text{ kHz}, R_S = 0 \Omega$		90		nV/√Hz
∋ <sub>NO</sub>	noise <sup>(5)</sup>	$f_{B} = 0.1$ Hz to 10 Hz, $R_{S} = 0 \Omega$		7.7		μV <sub>PP</sub>
		f = 1 kHz		170		fA/√Hz
l <sub>n</sub>	Noise current	$f_B = 0.1$ Hz to 10 Hz, G = 100		4.7		pA <sub>PP</sub>
GAIN			1			ליי יא
G	Gain equation			1 + (50 kΩ / R <sub>G</sub> )		V/V
-	Range of gain		1		1000	V/V
		$G = 1, V_0 = \pm 10 V$		±0.005%	±0.02%	•,•
		$G = 10, V_0 = \pm 10 V$ $G = 10, V_0 = \pm 10 V$		±0.025%	±0.15%	
GE	Gain error	$G = 100, V_0 = \pm 10 V$ $G = 100, V_0 = \pm 10 V$		±0.025%	±0.15%	
		$G = 1000, V_0 = \pm 10 V$ $G = 1000, V_0 = \pm 10 V$		±0.025%	10.1370	
		$G = 1000, v_0 = \pm 10 v$ $G = 1, T_A = -40^{\circ}C \text{ to } +125^{\circ}C$		±0.05%	±5	
			1		±0	ppm/°C

Total offset, referred-to-input (RTI): V<sub>OS</sub> = (V<sub>OSI</sub>) + (V<sub>OSO</sub> / G).
 Offset drifts are uncorrelated. Input-referred offset drift is calculated using: ΔV<sub>OS(RTI)</sub> = √[ΔV<sub>OSI</sub><sup>2</sup> + (ΔV<sub>OSO</sub> / G)<sup>2</sup>]

Specified by characterization. (3)

Input voltage range of the INA828 input stage. The input range depends on the common-mode voltage, differential voltage, gain, and (4) reference voltage. See Typical Characteristic curves Figure 48 through Figure 51 for more information.

Total RTI voltage noise is equal to:  $e_{N(RTI)} = \sqrt{[e_{NI}^2 + (e_{NO} / G)^2]}$ (5)

The values specified for G > 1 do not include the effects of the external gain-setting resistor, R<sub>G</sub>. (6)

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# **Electrical Characteristics (continued)**

at $T_A = 25^{\circ}C$ , $V_S = \pm 15 V$ , $R_L = 10 k\Omega$ , $V_{REF} = 0 V$ , and $G = 1$ (unless oth	herwise noted)
--	----------------

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
		G = 1 to 10, $V_0$ = -10 V to +10 V, $R_L$ = 10 k $\Omega$		1	10	
	Onin analianati	G = 100, V <sub>O</sub> = $-10$ V to $+10$ V, R <sub>L</sub> = $10$ k $\Omega$			15	
	Gain nonlinearity	G = 1000, V <sub>O</sub> = $-10$ V to $+10$ V, R <sub>L</sub> = $10$ k $\Omega$			20	ppm
		G = 1 to 100, $V_O$ = -10 V to +10 V, $R_L$ = 2 k $\Omega$		30		
OUTP	UT					
	Voltage swing		(V–) + 0.15		(V+) – 0.15	V
	Load capacitance stability			1000		pF
Zo	Closed-loop output impedance	f = 10 kHz		1.3		Ω
I <sub>SC</sub>	Short-circuit current	Continuous to V <sub>S</sub> / 2		±18		mA
FREQ	UENCY RESPONSE				l	
		G = 1		2.0		MHz
BW	Bandwidth, −3 dB	G = 10		640		kHz
		G = 100		260		
		G = 1000		33		
SR	Slew rate	$G = 1, V_0 = \pm 10 V$		1.2		V/µs
		0.01%, G = 1 to 100, V <sub>STEP</sub> = 10 V		12		
		0.01%, G = 1000, V <sub>STEP</sub> = 10 V		40		μs
t <sub>S</sub>	Settling time	0.001%, G = 1 to 100, V <sub>STEP</sub> = 10 V		16		
		0.001%, G = 1000, V <sub>STEP</sub> = 10 V		50		
REFE	RENCE INPUT					
R <sub>IN</sub>	Input impedance			40		kΩ
	Voltage range		(V–)		(V+)	V
	Gain to output			1		V/V
	Reference gain error			0.01%		
POWE	R SUPPLY					
V	Dower ownels yelter-	Single supply	4.5		36	V
Vs	Power-supply voltage	Dual supply	±2.25		±18	v
	Quisseent surrent	V <sub>IN</sub> = 0 V		600	650	۵
Ι <sub>Q</sub>	Quiescent current	vs temperature, $T_A = -40^{\circ}C$ to $+125^{\circ}C$			850	μA



#### 6.6 Typical Characteristics



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## **Typical Characteristics (continued)**





#### **Typical Characteristics (continued)**





# **Typical Characteristics (continued)**





#### **Typical Characteristics (continued)**





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**ISTRUMENTS** 

EXAS

## **Typical Characteristics (continued)**







## **Typical Characteristics (continued)**



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# **Typical Characteristics (continued)**





#### **Typical Characteristics (continued)**



# 7 Detailed Description

# 7.1 Overview

The INA828 is a monolithic precision instrumentation amplifier incorporating a current-feedback input stage and a 4-resistor difference amplifier output stage. The differential input voltage is buffered by  $Q_1$  and  $Q_2$  and is forced across  $R_G$ , which causes a signal current to flow through  $R_G$ ,  $R_1$ , and  $R_2$ . The output difference amplifier,  $A_3$ , removes the common-mode component of the input signal and refers the output signal to the REF terminal. The  $V_{BE}$  and voltage drop across  $R_1$  and  $R_2$  produce output voltages on  $A_1$  and  $A_2$  that are approximately 0.8 V lower than the input voltages.

Each input is protected by two field-effect transistors (FETs) that provide a low series resistance under normal signal conditions, and preserve excellent noise performance. When excessive voltage is applied, these transistors limit input current to approximately 8 mA.

# 7.2 Functional Block Diagram





(1)

# 7.3 Feature Description

#### 7.3.1 Setting the Gain

Figure 52 shows that the gain of the INA828 is set by a single external resistor,  $R_G$ , connected between the RG pins (pins 1 and 8).





The value of  $R_G$  is selected according to:

$$G = 1 + \frac{50 \text{ k}\Omega}{\text{R}_{G}}$$

Table 1 lists several commonly-used gains and resistor values. The 50-k $\Omega$  term in Equation 1 comes from the sum of the two internal 25-k $\Omega$  feedback resistors. These on-chip resistors are laser-trimmed to accurate absolute values. The accuracy and temperature coefficients of these resistors are included in the gain accuracy and drift specifications of the INA828.

Table 1. Common	y-Used Gains a	and Resistor Values
-----------------	----------------	---------------------

DESIRED GAIN	R <sub>G</sub> (Ω)	NEAREST 1% R <sub>G</sub> (Ω)		
1	NC	NC		
2	50 k	49.9 k		
5	12.5 k	12.4 k		
10	5.556 k	5.49 k		
20	2.632 k	2.61 k		
50	1.02 k	1.02 k		
100	505.1	511		
200	251.3	249		
500	100.2	100		
1000	50.05	49.9		



#### 7.3.1.1 Gain Drift

The stability and temperature drift of the external gain setting resistor,  $R_G$ , also affects gain. The contribution of  $R_G$  to gain accuracy and drift can be determined from Equation 1.

The best gain drift of 5 ppm/°C (maximum) can be achieved when the INA828 uses G = 1 without  $R_G$  connected. In this case, gain drift is limited only by the slight mismatch of the temperature coefficient of the integrated 40-k $\Omega$  resistors in the differential amplifier (A<sub>3</sub>). At gains greater than 1, gain drift increases as a result of the individual drift of the 25-k $\Omega$  resistors in the feedback of A<sub>1</sub> and A<sub>2</sub>, relative to the drift of the external gain resistor R<sub>G</sub>. The low temperature coefficient of the internal feedback resistors significantly improves the overall temperature stability of applications using gains greater than 1 V/V over alternate solutions.

Low resistor values required for high gain can make wiring resistance important. Sockets add to the wiring resistance and contribute additional gain error (such as a possible unstable gain error) at gains of approximately 100 or greater. To assure stability, avoid parasitic capacitance of more than a few picofarads at  $R_G$  connections. Careful matching of any parasitics on both  $R_G$  pins maintains optimal CMRR over frequency; see *Typical Characteristics*, Figure 17.

#### 7.3.2 EMI Rejection

Texas Instruments developed a method to accurately measure the immunity of an amplifier over a broad frequency spectrum, extending from 10 MHz to 6 GHz. This method uses an EMI rejection ratio (EMIRR) to quantify the ability of the INA828 to reject EMI. The offset resulting from an input EMI signal can be calculated using Equation 2:

$$\Delta V_{OS} = \left(\frac{V_{RF\_PEAK}^{2}}{100 \text{ mV}_{P}}\right) \cdot 10^{-\left(\frac{EMIRR (dB)}{20}\right)}$$

where

• V<sub>RE PEAK</sub> is the peak amplitude of the input EMI signal.

(2)

Figure 53 and Figure 54 show the INA828 EMIRR graph for both differential and common-mode EMI rejection across this frequency range. Table 2 shows the EMIRR values for the INA828 at frequencies commonly encountered in real-world applications. Applications listed in Table 2 can be centered on or operated near the particular frequency shown. Depending on the end-system requirements, additional EMI filters may be required near the signal inputs of the system, as well as incorporating known good practices such as using short traces, low-pass filters, and damping resistors combined with parallel and shielded signal routing.



FREQUENCY	APPLICATION OR ALLOCATION	DIFFERENTIAL EMIRR	COMMON-MODE EMIRR
400 MHz	Mobile radio, mobile satellite, space operation, weather, radar, ultrahigh-frequency (UHF) applications	48 dB	87 dB
900 MHz	Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (up to 1.6 GHz), GSM, aeronautical mobile, UHF applications	52 dB	98 dB
1.8 GHz	GSM applications, mobile personal communications, broadband, satellite, L-band (1 GHz to 2 GHz)	94 dB	51 dB
2.4 GHz	802.11b, 802.11g, 802.11n, Bluetooth <sup>®</sup> , mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2 GHz to 4 GHz)	66 dB	57 dB
3.6 GHz	Radiolocation, aero communication and navigation, satellite, mobile, S-band	79 dB	87 dB
5 GHz	802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4 GHz to 8 GHz)	90 dB	92 dB

#### Table 2. INA828 EMIRR for Frequencies of Interest

#### 7.3.3 Input Common-Mode Range

The linear input voltage range of the INA828 input circuitry extends within 2 Volts of both power supplies and maintains excellent common-mode rejection throughout this range. The common-mode range for the most common operating conditions are shown in Figure 55, Figure 50, and Figure 51. The common-mode range for other operating conditions is best calculated using the *INA common-mode range calculating tool*. The INA828 device can operate over a wide range of power supplies and VREF configurations, thus providing a comprehensive guide to common-mode range limits for all possible conditions is impractical.



#### 7.3.4 Input Protection

The inputs of the INA828 device are individually protected for voltages up to  $\pm 40$  V. For example, a condition of -40 V on one input and 40 V on the other input does not cause damage. Internal circuitry on each input provides low series impedance under normal signal conditions. If the input is overloaded, the protection circuitry limits the input current to a value of approximately 8 mA.



Figure 59. Input Current Path During an Overvoltage Condition

During an input overvoltage condition, current flows through the input protection diodes into the power supplies, see Figure 59. If the power supplies are unable to sink current, then Zener diode clamps (ZD1 and ZD2 in Figure 59) must be placed on the power supplies to provide a current pathway to ground. Figure 60 illustrates the input current for input voltages from -40 V to +40 V when the INA828 is powered by  $\pm 15$ -V supplies.



Figure 60. Input Current vs Input Overvoltage



The INA828 operates over a power-supply range of 4.5 V to 36 V (±2.25 V to ±18 V).

#### CAUTION

Supply voltages higher than 40 V ( $\pm$ 20 V) can permanently damage the device. Parameters that vary over supply voltage or temperature are shown in the *Typical Characteristics* section of this data sheet.

## 7.4 Device Functional Modes

The INA828 has a single functional mode and is operational when the power-supply voltage is greater than 4.5 V ( $\pm$ 2.25 V). The maximum power-supply voltage for the INA828 is 36 V ( $\pm$ 18 V).

# 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 8.1 Reference Terminal

The output voltage of the INA828 is developed with respect to the voltage on the reference terminal, REF. Often, in dual-supply operation, the reference pin (pin 6) is connected to the low-impedance system ground. In single-supply operation, offsetting the output signal to a precise mid-supply level is useful (for example, 2.5 V in a 5-V supply environment). To accomplish this level shift, a voltage source must be connected to the REF pin to level-shift the output so that the INA828 can drive a single-supply ADC.

The voltage source applied to the reference terminal must have a low output impedance. As illustrated in Figure 61, any resistance at the reference terminal (shown as  $R_{REF}$  in Figure 61) is in series with one of the internal 40-k $\Omega$  resistors.



Figure 61. Parasitic Resistance Shown at the Reference Terminal

The parasitic resistance at the reference terminal,  $R_{REF}$ , creates an imbalance in the 4 resistors of the internal difference amplifier, resulting in degraded common-mode rejection ratio (CMRR). Figure 62 shows the degradation in CMRR of the INA828 for increasing resistance at the reference terminal. For the best performance, keep the source impedance to the REF terminal,  $R_{REF}$ , below 5  $\Omega$ .



# **Reference Terminal (continued)**



Figure 62. The Effect of Increasing Resistance at the Reference Terminal

Voltage reference ICs are an excellent option for providing a low-impedance voltage source for the reference terminal. However, if a resistor voltage divider is used to generate a reference voltage, it must be buffered by an op amp as shown in Figure 63 to avoid CMRR degradation.



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#### Figure 63. Using an Op Amp to Buffer Reference Voltages



#### 8.2 Input Bias Current Return Path

The input impedance of the INA828 is extremely high—approximately 100 G $\Omega$ . However, a path must be provided for the input bias current of both inputs. This input bias current is typically 150 pA. High input impedance means that this input bias current changes very little with varying input voltage.

Input circuitry must provide a path for this input bias current for proper operation. Figure 64 shows various provisions for an input bias current path. Without a bias current path, the inputs float to a potential that exceeds the common-mode range of the INA828, and the input amplifiers saturate. If the differential source resistance is low, the bias current return path can be connected to one input (as shown in the thermocouple example in Figure 64). With a higher source impedance, using two equal resistors provides a balanced input with possible advantages of a lower input offset voltage as a result of bias current and better high-frequency common-mode rejection.



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#### Figure 64. Providing an Input Common-Mode Current Path



## 8.3 PCB Assembly Effects on Precision

The printed-circuit board (PCB) assembly process, including reflow soldering, imparts thermal stresses on the INA828 which can degrade the precision of the device and must be considered in the development of very-high-precision systems. Baking the PCBs after the assembly process can restore the precision of the device to preassembly values. Figure 65, Figure 66, and Figure 67 illustrate the effect of reflow soldering on the typical distribution of input offset voltage of the INA828. Figure 65 shows the distribution of input offset voltage for a set of INA828 devices prior to the PCB assembly process. Exposing the INA828 to a JEDEC-standard thermal profile for reflow soldering produces the histogram shown in Figure 66 on another set of INA828 devices. The standard deviation of input offset voltage has almost doubled due to the thermal stress imparted to the INA828 from the reflow process. However, baking INA828 units for 30 minutes at 125°C after the reflow soldering process produced the distribution given in Figure 67. The post-reflow bake restored the standard deviation of the input offset voltage to pre-assembly levels.





## 8.4 Typical Application

Figure 68 shows a three-terminal programmable-logic controller (PLC) design for the INA828. This PLC reference design accepts inputs of  $\pm 10$  V or  $\pm 20$  mA. The output is a single-ended voltage of 2.5 V  $\pm 2.3$  V (or 200 mV to 4.8 V). Many PLCs typically have these input and output ranges.



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Figure 68. PLC Input (±10 V, 4 mA to 20 mA)

#### 8.4.1 Design Requirements

For this application, the design requirements are:

- 4-mA to 20-mA input with less than 20-Ω burden
- ±20-mA input with less than 20-Ω burden
- ±10-V input with impedance of approximately 100 kΩ
- Maximum 4-mA to 20-mA or ±20mA burden voltage equal to ±0.4 V
- Output range within 0 V to 5 V

#### 8.4.2 Detailed Design Procedure

There are two modes of operation for the circuit shown in : current input and voltage input. This design requires  $R_1 >> R_2 >> R_3$ . Given this relationship, Equation 3 calculates the current input mode transfer function.

$$V_{OUT-I} = V_D \times G + V_{REF} = -(I_{IN} \times R_3) \times G + V_{REF}$$

where

- G represents the gain of the instrumentation amplifier
- V<sub>D</sub> represents the differential voltage at the INA828 inputs
- V<sub>REF</sub> is the voltage at the INA828 REF pin
- I<sub>IN</sub> is the input current

Equation 4 shows the transfer function for the voltage input mode.

$$V_{OUT-V} = V_{D} \times G + V_{REF} = -\left(V_{IN} \times \frac{R_{2}}{R_{1} + R_{2}}\right) \times G + V_{REF}$$

where

• V<sub>IN</sub> is the input voltage

 $R_1$  sets the input impedance of the voltage input mode. The minimum typical input impedance is 100 k $\Omega$ . 100 k $\Omega$  is selected for  $R_1$  because increasing the  $R_1$  value also increases noise. The value of  $R_3$  must be extremely small compared to  $R_1$  and  $R_2$ . 20  $\Omega$  for  $R_3$  is selected because that resistance value is much smaller than  $R_1$  and yields an input voltage of ±400 mV when operated in current mode (±20 mA).

(4)

(3)



#### **Typical Application (continued)**

Use Equation 5 to calculate R<sub>2</sub> given V<sub>D</sub> = ±400 mV, V<sub>IN</sub> = ±10 V, and R<sub>1</sub> = 100 k $\Omega$ .

$$V_{\rm D} = V_{\rm IN} \times \frac{R_2}{R_1 + R_2} \to R_2 = \frac{R_1 \times V_{\rm D}}{V_{\rm IN} - V_{\rm D}} = 4.167 \, \rm k\Omega$$
(5)

The value obtained from Equation 5 is not a standard 0.1% value, so 4.17 k $\Omega$  is selected. R<sub>1</sub> and R<sub>2</sub> also use 0.1% tolerance resistors to minimize error.

Use Equation 6 to calculate the ideal gain of the instrumentation amplifier.

$$G = \frac{V_{OUT} - V_{REF}}{V_{D}} = \frac{4.8 \text{ V} - 2.5 \text{ V}}{400 \text{ mV}} = 5.75 \frac{\text{V}}{\text{V}}$$
(6)

Equation 7 calculates the gain-setting resistor value using the INA828 gain equation, Equation 1.

$$R_{G} = \frac{50 \text{ k}\Omega}{\text{G}-1} = \frac{50 \text{ k}\Omega}{5.75 - 1} = 10.5 \text{ k}\Omega$$
(7)

10.5 k $\Omega$  is a standard 0.1% resistor value that can be used in this design.

#### 8.4.3 Application Curves

Figure 69 and Figure 70 show typical characteristic curves for the circuit in Figure 68.



INA828 SBOS792 – AUGUST 2017

#### 8.5 Other Application Examples

#### 8.5.1 Resistance Temperature Detector Interface

Figure 71 illustrates a 3-wire interface circuit for resistance temperature detectors (RTDs). The circuit incorporates analog linearization and has an output voltage range from 0 to 5 V. The linearization technique employed is described in *Analog linearization of resistance temperature detectors*. Series and parallel combinations of standard 1% resistor values are used to achieve less than 0.02°C of error over a 200°C temperature span.



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# 9 Power Supply Recommendations

The nominal performance of the INA828 is specified with a supply voltage of  $\pm 15$  V and mid-supply reference voltage. The device can also be operated using power supplies from  $\pm 1.5$  V (3 V) to  $\pm 18$  V (36 V) and non mid-supply reference voltages with excellent performance. Parameters that can vary significantly with operating voltage and reference voltage are illustrated in the *Typical Characteristics* section.

# 10 Layout

#### **10.1 Layout Guidelines**

Attention to good layout practices is always recommended. For best operational performance of the device, use good PCB layout practices, including:

- Care must be taken to assure that both input paths are well-matched for source impedance and capacitance to avoid converting common-mode signals into differential signals. In addition, parasitic capacitance at the gain-setting pins can also affect CMRR over frequency. For example, in applications that implement gain switching using switches or PhotoMOS<sup>®</sup> relays to change the value of R<sub>G</sub>, select the component so that the switch capacitance is as small as possible.
- Noise can propagate into analog circuitry through the power pins of the circuit as a whole and of the device itself. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
  - Connect low-ESR, 0.1-µF ceramic bypass capacitors between each supply pin and ground, placed as close to the device as possible. A single bypass capacitor from V+ to ground is applicable for singlesupply applications.
- To reduce parasitic coupling, run the input traces as far away from the supply or output traces as possible. If
  these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better than in
  parallel with the noisy trace.
- Place the external components as close to the device as possible. As illustrated in Figure 74, keeping R<sub>G</sub> close to the pins minimizes parasitic capacitance.
- Keep the traces as short as possible.



## 10.2 Layout Example



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#### Figure 74. Example Schematic and Associated PCB Layout



# **11 Device and Documentation Support**

#### **11.1 Documentation Support**

#### 11.1.1 Related Documentation

For related documentation see the following:

- REF50xx Low-Noise, Very Low Drift, Precision Voltage Reference
- OPA191 Low-Power, Precision, 36-V, e-trim CMOS Amplifier
- TINA-TI software folder
- INA Common-Mode Range Calculator

#### 11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### **11.3 Community Resources**

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

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**Design Support TI's Design Support** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

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#### 11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 11.6 Glossary

#### SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

# 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



25-Aug-2017

# PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
INA828ID	PREVIEW	SOIC	D	8	75	TBD	Call TI	Call TI	-40 to 125		
INA828IDR	PREVIEW	SOIC	D	8	2500	TBD	Call TI	Call TI	-40 to 125		

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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